Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/722,906	HALLEE ET AL.	
Examiner	Art Unit	
David T. Eidoi	3728	

SEARCHED				
Class	Subclass	Date	Examiner	
Class		Date	LABITATION	
206	349 372 373 379	6/26/2006	DTF	
211	69 70.6	6/26/2006	DTF	
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Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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